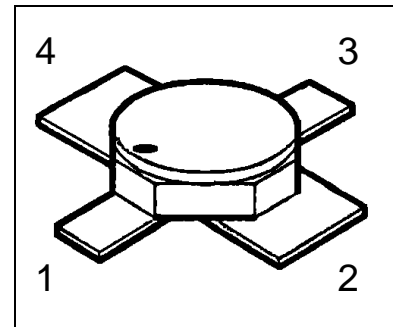


**HiRel NPN Silicon Germanium RF Transistor**

- **HiRel Discrete and Microwave Semiconductor**
- High gain low noise RF transistor
- High maximum stable gain:  $G_{ms}$  24dB at 1.8 GHz
- Noise figure  $F = 0.8$  dB at 1.8 GHz  
Noise figure  $F = 1.1$  dB at 6 GHz
- Hermetically sealed microwave package



**ESD:** Electrostatic discharge sensitive device, observe handling precautions!

Type	Marking	Pin Configuration				Package
		1	2	3	4	
BFY640B	-	C	E	B	E	Micro-X

**Maximum Ratings**

Parameter	Symbol	Values	Unit
Collector-emitter voltage $T_a > 0\text{ °C}$ $T_a \leq 0\text{ °C}$	$V_{CEO}$	4.0 3.7	V V
Collector-base voltage	$V_{CBO}$	13	V
Emitter-base voltage	$V_{EBO}$	1.2	V
Collector current <sup>1)</sup>	$I_C$	50	mA
Base current	$I_B$	3	mA
Junction temperature	$T_j$	175	°C
Operating temperature range	$T_{op}$	-65...+175	°C
Storage temperature range	$T_{stg}$	-65...+175	°C

**Thermal Resistance**

Junction-soldering point <sup>2)</sup>	$R_{th JS}$	325	K/W
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**Notes.:**

- 1) For  $T_A > 25\text{ °C}$  the derating of  $I_C$  has to be considered. Nomograms will be available on request.  
2)  $T_S$  is measured on the emitter lead at the soldering point to the pcb.

**Electrical Characteristics**

 at  $T_A=25^\circ\text{C}$ ; unless otherwise specified

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
<b>DC Characteristics</b>					
Collector-base cutoff current $V_{CB} = 5\text{ V}, I_E = 0$	$I_{CBO}$	-	-	10	$\mu\text{A}$
Collector-emitter cutoff current <sup>1)</sup> $V_{CE} = 4.0\text{ V}, I_B = 0.1\ \mu\text{A}$	$I_{CEX}$	-	-	200	$\mu\text{A}$
Emitter-base cutoff current $V_{EB} = 1.2\text{ V}, I_C = 0$	$I_{EBO}$	-	-	5	$\mu\text{A}$
DC current gain $I_C = 30\text{ mA}, V_{CE} = 3\text{ V}$	$h_{FE}$	135	180	250	-

**AC Characteristics**

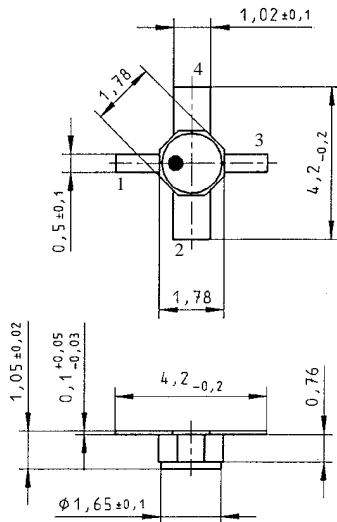
Collector-base capacitance $V_{CB} = 2\text{ V}, V_{BE} = v_{be} = 0, f = 1\text{ MHz}$	$C_{CB}$	-	0.07	-	pF
Collector-emitter capacitance $V_{CE} = 2\text{ V}, V_{BE} = v_{be} = 0, f = 1\text{ MHz}$	$C_{CE}$	-	0.45	-	pF
Emitter-base capacitance $V_{EB} = 0.5\text{ V}, V_{CB} = v_{cb} = 0, f = 1\text{ MHz}$	$C_{EB}$	-	0.6	-	pF
Noise Figure ( $Z_S = Z_{s\text{opt}}$ ) $I_C = 5\text{ mA}, V_{CE} = 3\text{ V}, f = 1.8\text{ GHz}$ $I_C = 5\text{ mA}, V_{CE} = 3\text{ V}, f = 6.0\text{ GHz}$	F	-	0.8 1.1	-	dB
Insertion power gain ( $Z_S = Z_L = 50\ \Omega$ ) $I_C = 30\text{ mA}, V_{CE} = 3\text{ V}, f = 1.8\text{ GHz}$ $I_C = 30\text{ mA}, V_{CE} = 3\text{ V}, f = 6.0\text{ GHz}$	$ S_{21e} ^2$	-	22.5 12.5	-	dB
Power gain ( $Z_S = Z_{S\text{opt}}, Z_L = Z_{L\text{opt}}$ ) $I_C = 30\text{ mA}, V_{CE} = 3\text{ V}, f = 1.8\text{ GHz}$	$G_{ms}^{2)}$	-	24	-	dB
Power gain ( $Z_S = Z_{S\text{opt}}, Z_L = Z_{L\text{opt}}$ ) $I_C = 30\text{ mA}, V_{CE} = 3\text{ V}, f = 6.0\text{ GHz}$	$G_{ma}^{2)}$	-	14	-	dB

**Notes.:**

 1) This Test assures  $V(BR)CE0 > 4.0\text{ V}$ 

$$2) \quad G_{ma} = \left| \frac{S_{21}}{S_{12}} \right| (k - \sqrt{k^2 - 1}), \quad G_{ms} = \left| \frac{S_{21}}{S_{12}} \right|$$

## Micro-X Package



Edition 2010-06

Published by

Infineon Technologies AG

81726 München, Germany

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